

Notice of References Cited

Application/Control No.

10/050,639

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

DuyVu n Deo

Art Unit

1765

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,268,590	12-1993	Pfiester et al.	257/764
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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